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## PATENT APPLICATION

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OIPE 40 8	<u>,</u>	IN THE UNITED STATES PATE	NT AN	ID TRADEMARK OFFICE
	/ n re App	lication of:	) :	
7	OMON.	ARI NAKAYAMA, et al.	) :	-
1	Applicati	on No.: 10/559,799	) :	
!	Int'l. Filing Date: June 9, 2005			
	For:	FIELD EFFECT TRANSISTOR AND PRODUCTION PROCESS	) : )	November 3, 2006

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

**THEREOF** 

## INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56 and in accordance with the practice under 37 C.F.R. §§ 1.97 and 1.98, the Examiner's attention is directed to the documents listed on the enclosed Form PTO-1449. Copies of the listed documents, other than the U.S. patent documents, are enclosed.

Japan 2004-63977, Japan 2004-63975, Japan 2004-128469, Japan 2004-6700, Japan 2004-146796, U.S. Patent No. 6,861,377, and U.S. Publication No. 2004/0131782 were cited in the International Search Report and/or Written Opinion which issued in the corresponding international application. A copy of the International Search Report and a copy of the Written Opinion are enclosed.

The following documents are discussed at the following pages of the specification:

	Page(s)
<u>Documents</u>	2
A. Assadi, et al., Appl. Phys. Lett., Vol. 53, No. 3,	2
July 18, 1988	<u>~</u> .
H. Fuchigami, et al., Appl. Phys. Lett., Vol. 63, No. 10,	2
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Janos Veres, et al., Advanced Functional Materials, Vol. 13,	7
No. 3, March 2003	
Zhenan Bao, et al., Chem. Mater., Vol. 9, No. 6, 1997	5
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An English-language abstract for each of the Japanese documents listed on the Form PTO-1449 is enclosed.

According to a commercial database, U.S. Patent No. 6,861,377 is in the same patent family as Japan 2004-6700, U.S. Patent 6,107,117 is in the same patent family as Japan 10-190001, and U.S. Publication No. 2004/0131782 is in the same patent family as Japan 2004-146796.

This Information Disclosure Statement is being filed before the issuance of a first Office Action on the merits. Therefore, no fee under 37 C.F.R. § 1.97(c)(2) is believed due. Nevertheless, the Commissioner may charge Deposit Account No. 06-1205, should any fee be due for filing this paper.

EFS-Web Receipt date: 11/06/2006

Applicants request that the above information be considered by the Examiner and that a copy of the enclosed Form PTO-1449 be initialed and returned indicating that such information has been considered.

Applicants' undersigned attorney may be reached in our Costa Mesa, California office at (714) 540-8700. All correspondence should continue to be directed to our below-listed address.

Respectfully submitted,

Damond E. Vadnais Attorney for Applicants Registration No.: 52,310

FITZPATRICK, CELLA, HARPER & SCINTO 30 Rockefeller Plaza New York, New York 10112-3800 Facsimile: (212) 218-2200 EFS-Web Receipt date: 11/06/2006

ARTMENT OF COMMERCE AND TRADEMARK OFFICE SENCES CITED BY APPLICATION OF THE PROPERTY OF THE PR	NT(S) 8	INT'L FILING DATE:  June 9, 20	ONARI NAKAYA	MA, et al.	4				
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l	DATE	NAME	CLASS	SUBCLASS	IF APPROPRIATE				
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6.107,117	08/22/00	Bao, et al.	438	99					
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	FC	DREIGN PATENT DOCUMENTS			TRANSLATION				
DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	YES/NO/ OR ABSTRACT				
	05/20/04	Japan			Abstract				
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		(Including Author Title, Date, Pe	ertinent Pages, Etc.)						
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy Sheet\_1\_ of \_\_1\_ of this form with next communication to applicant.

Form #61